GSM3385XF

30V P-Channel MOSFETs

Product Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

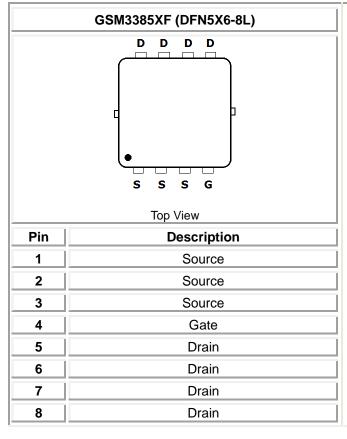
Features

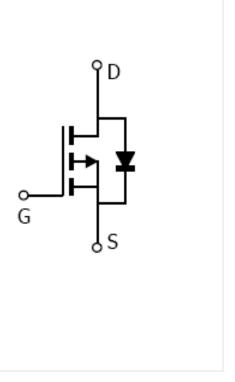
- -30V, -54A, $R_{DS(ON)}$ <8m Ω @ V_{GS} =-10V
- Fast switching
- Suit for -4.5V Gate Drive Applications
- Green Device Available
- DFN5X6-8L package design

Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application

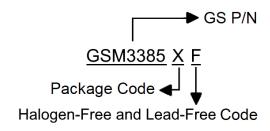
Packages & Pin Assignments





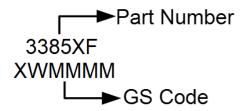


Ordering Information



Part Number	Package	Quantity Reel
GSM3385XF	DFN5X6-8L	3000 PCS

Marking Information



Absolute Maximum Ratings

Tc=25°C Unless otherwise noted

Symbol	Parameter		Typical	Unit
V _{DS}	Drain-Source Voltage		-30	V
V _G s	Gate-Source Voltage		±25	V
		Tc=25°C	-54	A
I _D Continuous Dra	Continuous Drain Current	Tc=100°C	-34	
I _{DM}	Pulsed Drain Current ¹		-180	А
		Tc=25°C	37.9	W
P _D	Power Dissipation	T _C =100°C	15.2	
TJ	Operating Junction Temperature Range		-55 to +150	$^{\circ}\mathbb{C}$
Тѕтс	Storage Temperature Range		-55 to +150	$^{\circ}\mathbb{C}$
R _{eJC}	Thermal Resistance-Junction to Case		3.3	°C/W



Electrical Characteristics TJ=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
	Static	characteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-30			V	
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1.2	-1.6	-2.5	V	
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±25V			±100	nA	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-30V, V _{GS} =0V			-1	uA	
V _{SD}	Diode Forward Voltage ³	V _{GS} =0V, I _S =-1A			-1	V	
R _{DS(on)}	Dunin Course On Beninters 3	V _{GS} =-10V, I _D =-10A		6.9	7.8	mΩ	
	Drain-Source On-Resistance ³	V _{GS} =-4.5V, I _D =-6A		10.7	12.3		
	Gate cha	rge characteristics					
Q_g	Total Gate Charge ^{3,4}			68		nC	
Q_{gs}	Gate-Source Charge ^{3,4}	V _{DD} =-15V, V _{GS} =10V, I _D =-15A		10			
Q_{gd}	Gate-Drain Charge ^{3,4}	10- 10/1		12			
	Dynam	ic characteristics					
Ciss	Input Capacitance			4319			
Coss	Output Capacitance	V_{DS} =-15V, V_{GS} =0V, f=1.0MHz		439		pF	
Crss	Reverse Transfer Capacitance	1=1.01/11/12		299			
t _{d(on)}	Turn-On Time			12			
t r	Rise Time	V _{DD} =-15V, V _{GS} =-10V,		11			
t _{d(off)}	Turn-Off Time	Rg=3.3Ω, I _D =-15A		105		ns	
t _f	Fall Time			21			



Typical Performance Characteristics

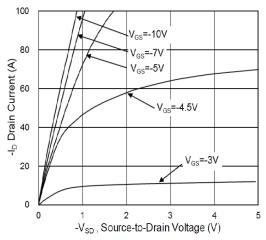


Figure 1. Output Characteristics

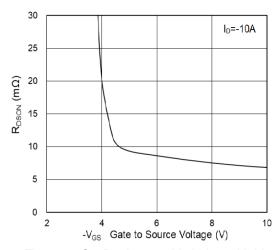


Figure 2. On-Resistance Variation with V_{GS}

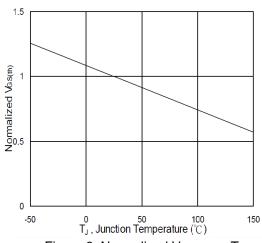


Figure 3. Normalized $V_{\text{GS(th)}}$ vs. T_{J}

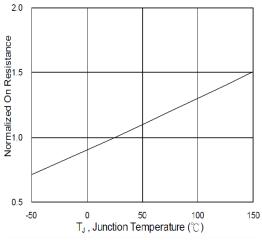


Figure 4. Normalized RDSON vs. TJ

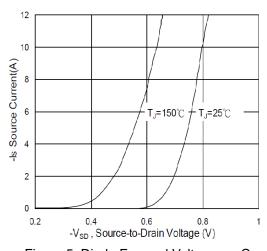


Figure 5. Diode Forward Voltage vs. Current

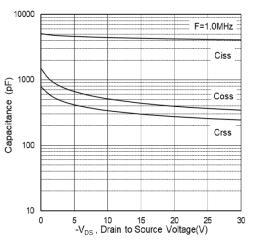


Figure 6. Capacitance

Typical Performance Characteristics (Continue)

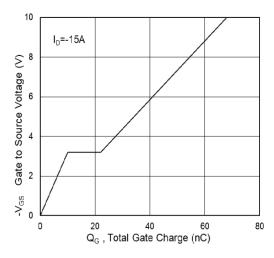


Figure 7. Gate Charge Waveform

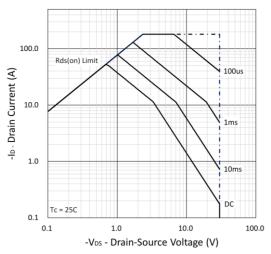


Figure 8. Maximum Safe Operating Area

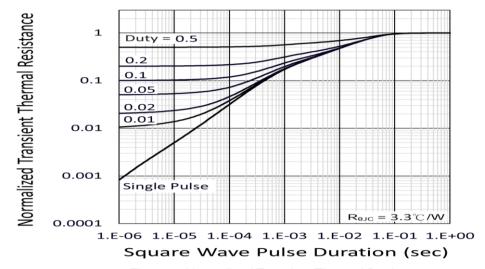
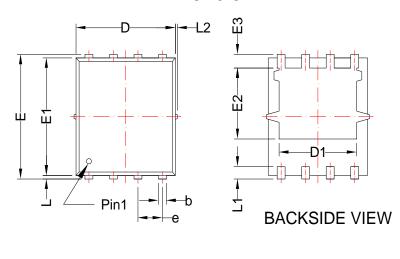


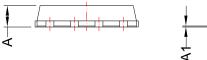
Figure 9. Normalized Transient Thermal Resistance



Package Dimension

DFN5X6-8L







DIMENSION D AND E1 DOES NOT INCLUDE MOLD FLASH,PROTRUSIONS OR GATE BURRS.MOLD FLASH,PROTRUSIONS OR GATE BURRS SHALL HOT EXCEED 0.5mm PER INTERLEAD FLASH OR PROTRUSIOB SHALL NOT EXCEED 0.5mm PER SIDE.

	Dimensions				
CVMDOL	Millimeters		Inches		
SYMBOL	MIN	MAX	MIN	MAX	
Α	0.80	1.20	0.031	0.047	
A 1	0.00	0.05	0.000	0.002	
b	0.25	0.51	0.010	0.020	
С	0.20	0.35	0.008	0.014	
D	4.90	5.40	0.193	0.213	
D1	3.40	4.60	0.134	0.181	
E	5.90	6.20	0.232	0.244	
E1	5.40	5.90	0.213	0.232	
E2	3.20	3.80	0.126	0.150	
E3	0.40	0.80	0.016	0.031	
H1	1.27 BSC		0.050 BSC		
L	0.1	0.25	0.004	0.010	
L1	0.45	0.75	0.018	0.030	
L2		0.15		0.006	



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